

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Rev. 2-32) PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. KIK01 P-322A	SERIAL NO.
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			
(Use several sheets if necessary)		APPLICANT(S) Kenichiro Kobayashi et al.	
		FILING DATE	GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
X.S	5 3 4 3 2 8 7	08/30/1994	Wilkins			
	4 6 2 1 0 6 3	11/04/1986	Wyatt et al.			
	4 7 9 4 3 8 4	12/27/1988	Jackson			
X.S	5 6 3 3 7 1 4	05/27/1997	Nyyssonen			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
						Y N
X.S	DE 19 7 3 9 6 79 A1 10/1998	Germany				
	2 7 0 1 7 6 2 08/1994	France				
	DE 19 8 1 7 6 64 A1 11/1999	Germany				
	DE 19 9 0 9 2 35 A1 09/1999	Germany				
X.S	DE 19 6 2 0 4 19 A1 11/1997	Germany				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	
X.S	U.S. Patent Application Publication 2002/0080264, publication date June 27, 2002 entitled METHOD AND APPARATUS FOR DIRECT IMAGE PICK-UP OF GRANULAR SPECK PATTERN GENERATED BY REFLECTING LIGHT OF LASER BEAM

EXAMINER	Wing S	DATE CONSIDERED	03/03/05 06/af/b6
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			